

# Search Notes



Application/Control No.

10/789,827

Examiner

Tien Dinh

Applicant(s)/Patent under Reexamination

HEIN ET AL.

Art Unit

3644

## SEARCHED

Class	Subclass	Date	Examiner
244	<del>53B</del> 53B	5/25/05	D
	129.4		
	129.5		
49	192		
	193	5/25/05	TD
137	15.1		
	15.2	5/25/05	D
60	270.1	5/25/05	TD

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Same		9/10/05	D
no			
abandon			

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East Text.	5/23/05	D